Notice of References Cited Application/Control No. 10/792,181 Examiner Huy D. Nguyen Applicant(s)/Patent Under Reexamination TROSSEN, DIRK Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0054796	03-2003	Tamaki et al.	455/406
*	В	US-2004/0142686	07-2004	Kirkup et al.	455/420
*	С	US-2003/0061358	03-2003	Piazza et al.	709/227
*	D	US-2004/0117358	06-2004	von Kaenel et al.	707/003
*	Ш	US-2004/0123118	06-2004	Dahan et al.	713/189
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP02002209028A	07-2002	Japan	Sakajura, Takashi	H04M015/00
	0					
	Р					
	Q					
	R					
	s					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

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